Power MOSFET

30 V, 53 A, Single N-Channel, SO-8 FL

Features

- Low RDS(on) to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These are Pb-Free Devices

Applications

- CPU Power Delivery
- DC-DC Converters
- Low Side Switching

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter			Symbol	Value	Unit	
Drain-to-Source Voltage			V_{DSS}	30	V	
Gate-to-Source Voltage			V_{GS}	20	V	
Continuous Drain Current Raja		$T_A = 25^{\circ}C$	Ι _D	11	Α	
(Note 1)		$T_A = 85^{\circ}C$		8.0		
Power Dissipation R _{θJA} (Note 1)		T _A = 25°C	P _D	2.2	W	
Continuous Drain		$T_A = 25^{\circ}C$	ID	7.0	Α	
Current R _{0JA} (Note 2)	Steady State	T _A = 85°C		5.0		
Power Dissipation R _{θJA} (Note 2)	State	T _A = 25°C	P_{D}	0.88	W	
Continuous Drain		$T_C = 25^{\circ}C$	Ι _D	53	Α	
Current R _{θJC} (Note 1)		T _C = 85°C		38		
Power Dissipation R _{θJC} (Note 1)		T _C = 25°C	P_{D}	47.2	W	
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	106	Α	
Operating Junction and Storage Temperature		T _J , T _{STG}	–55 to +150	°C		
Source Current (Body Diode)		IS	46	Α		
Drain to Source dV/dt		dV/dt	6.0	V/ns		
Single Pulse Drain-to-Source Avalanche Energy (V_{DD} = 50 V, V_{GS} = 10 V, I_L = 24 A_{pk} , L = 1.0 mH, R_G = 25 Ω)		EAS	286	mJ		
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C		

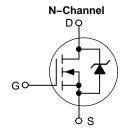
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

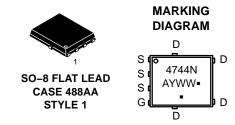


ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX		
30 V	10 mΩ @ 10 V	53 A		
30 V	14 mΩ @ 4.5 V	33 A		





4744N = Specific Device Code A = Assembly Location

Y = Year WW = Work Week

= Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4744NT1G	SO-8 FL (Pb-Free)	1500 Tape & Reel
NTMFS4744NT3G	SO-8 FL (Pb-Free)	5000 Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	2.65	
Junction-to-Ambient - Steady State (Note 1)	$R_{ heta JA}$	56.9	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{ hetaJA}$	142.4	

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS ($T_J = 25$ °C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS				•			
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				10		mV/°C
Zero Gate Voltage Drain Current	$V_{OS} = 0 V,$ $V_{DS} = 24 V$		T _J = 25 °C			1.0	
		V _{DS} = 24 V				10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = 20 V				100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D$	= 250 μΑ	1.5		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	$V_{GS} = 10 \text{ V to}$	I _D = 30 A		7.6		
		11.5 V	I _D = 15 A		7.3		
			I _D = 10 A		7.3	10	
		$V_{GS} = 4.5 \text{ V}$	I _D = 30 A		10.4		mΩ
			I _D = 15 A		10.1		
			I _D = 10 A		9.9	14	<u>] </u>
Forward Transconductance	9FS	V _{DS} = 15 V, I _D = 15 A			25		S
CHARGES, CAPACITANCES & GATE RESIS	TANCE						
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 12 V			1300		pF
Output Capacitance	C _{OSS}				550		
Reverse Transfer Capacitance	C _{RSS}				132		1
Total Gate Charge	$Q_{G(TOT)}$	V _{GS} = 4.5 V, V _{DS} = 15 V; I _D = 30 A			10	17	
Threshold Gate Charge	Q _{G(TH)}				0.9		nC
Gate-to-Source Charge	Q_{GS}				1.8		
Gate-to-Drain Charge	Q_{GD}				5.9		
Total Gate Charge	$Q_{G(TOT)}$	V _{GS} = 11.5 V, V _{DS} = 15 V; I _D = 30 A			25	37	nC
SWITCHING CHARACTERISTICS (Note 4)							
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}, I_{D} = 30 \text{ A},$ $R_{G} = 3.0 \Omega$			12		
Rise Time	t _r				203]
Turn-Off Delay Time	t _{d(OFF)}				14		ns
Fall Time	t _f				83		1

- 3. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.
- 4. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	ote 4)				•		
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = 11.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 30 \text{ A}, R_{G} = 3.0 \Omega$			7.0		- ns
Rise Time	t _r				94		
Turn-Off Delay Time	t _{d(OFF)}				23		
Fall Time	t _f				4.7		
DRAIN-SOURCE DIODE CHARACT	ERISTICS						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V, I _S = 30 A	T _J = 25°C		0.78	1.2	
			T _J = 125°C		0.7		V
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 30 \text{ A}$			37	60	ns
Charge Time	t _a				21		
Discharge Time	t _b				17		
Reverse Recovery Charge	Q_{RR}				37		nC
PACKAGE PARASITIC VALUES					•		
Source Inductance	L _S	- - T _A = 25°C			0.65		nΗ
Drain Inductance	L _D				0.005		1
Gate Inductance	L _G				1.84		
Gate Resistance	R_{G}				2.0	5.0	Ω

^{3.} Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$. 4. Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES

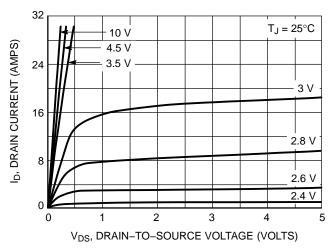


Figure 1. On-Region Characteristics

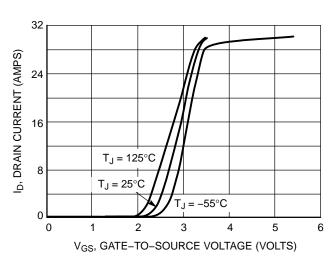


Figure 2. Transfer Characteristics

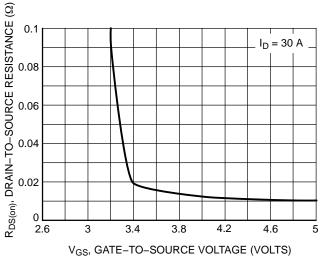


Figure 3. On-Resistance vs. Gate-to-Source Voltage

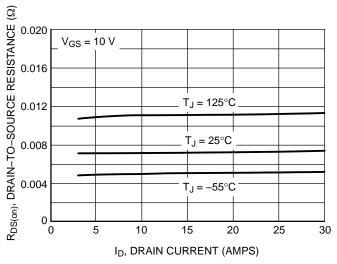


Figure 4. On–Resistance vs. Drain Current and Temperature

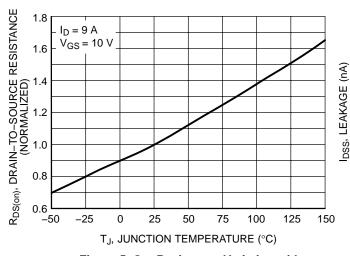


Figure 5. On–Resistance Variation with Temperature

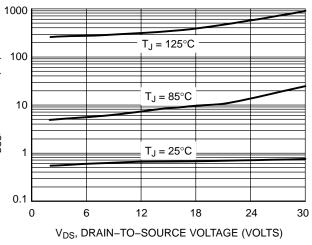
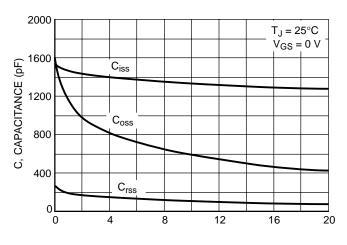


Figure 6. Drain-to-Source Leakage Current vs. Drain Voltage

TYPICAL PERFORMANCE CURVES



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

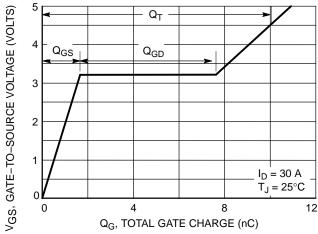


Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge



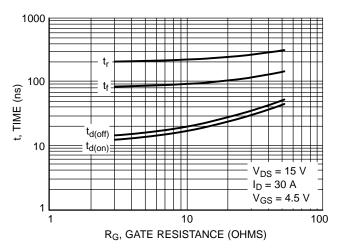


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

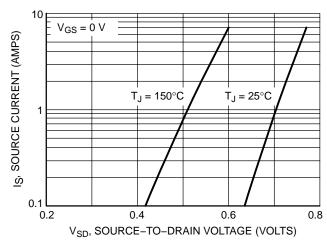


Figure 10. Diode Forward Voltage vs. Current

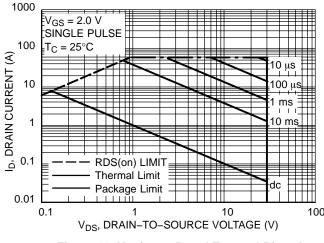


Figure 11. Maximum Rated Forward Biased Safe Operating Area

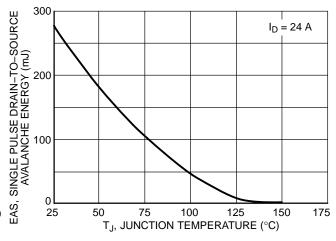


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL PERFORMANCE CURVES

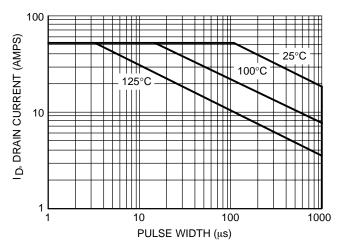
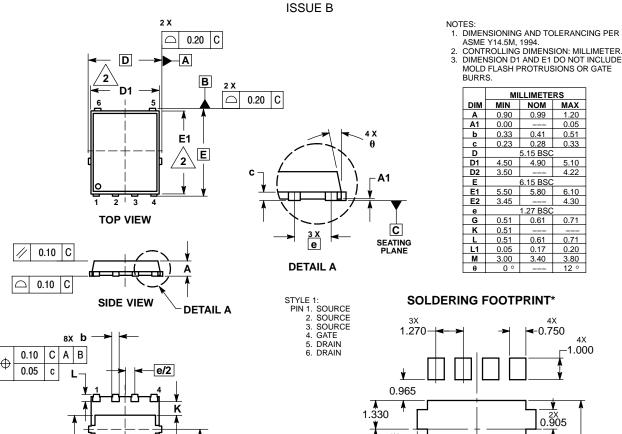


Figure 13. Avalanche Characteristics

PACKAGE DIMENSIONS

SO-8 FLAT LEAD CASE 488AA-01



М

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

4.560

→ 1.530

0.495

3.200

ON Semiconductor and un are registered trademarks of Semiconductor Components Industries, LLC (SCILLC). SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

E2

BOTTOM VIEW

G

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA

Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free USA/Canada

Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910

Japan Customer Focus Center Phone: 81-3-5773-3850

ON Semiconductor Website: www.onsemi.com

MILLIMETERS

NOM

0.99

0.41

0.28

4.90

6.15 BS

5.80

.27 BS

0.61

0.61

0.17

3.40

-0.750

0.905

0.475

5.15 BS

0.33

4.50

3.50

5.50

3.45

0.51

3.00

MAX

1.20 0.05

0.51

0.33

5.10

4.22

6.10

4.30

0.71

0.71

0.20

3.80

4X

1.000

4.530

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative